Search Notes



App	licati	on/C	ontro	l No
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10534992

Applicant(s)/Patent Under Reexamination

ETTORRE ET AL.

Examiner

Art Unit

LEILA MALEK

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SEARCHED

Class	Subclass	Date	Examiner
375	371,354,355,316	11/6/2008	L.M.
370	320	11/6/2008	L.M.

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Search Notes	Date	Examiner
EAST, IEEE, Consulted M. Ghayour, Inventor Name Search	11/6/2008	L.M.

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner
375	354,355,316	11/6/2008	L.M.
370	320	11/6/2008	L.M.

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